## SPECIFICATION FOR CONNECTOR USED FOR FPC/FFC WITH 1mm CONTACT SPACING COPING WITH AUTOMATIC MOUNTING & SMT HFW\_S-2STA\_LF / HFW\_S-2STB\_LF

### 1. SCOPE

This specification covers the requirements for the connector (HFW\_\_S-2ST\_\_LF) which the edge of 1mm spacing FPC(Flexible Printed circuit) and FFC(Flexible Flat Cable) are inserted into directly and connected to and which copes with automatic mounting and SMT.

### 2. APPLICABLE STANDARDS

JIS C 5402	Method for Test of Connectors for Electronic Equipment	
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- JIS C 0806 Packaging of Electronic Components on Continuous Tapes (Surface Mount Components)
- UL 94 TESTS FOR FLAMMABILITY OF PLASTIC MATERIALS FOR PARTS IN DEVICES AND APPLIANCES.
- 3. CATALOG No.

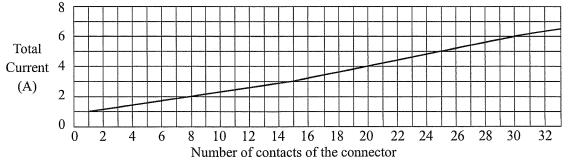
	HFW	20	S		2	ST	В	E1	LF
Series		T	T	-	T				
Number of Contacts									
Straight									
For FPC/FFC									
Cope with automatic mounting & SMT									
Contact plating									
A: Selective gold plating									
B: All gold plating									
Plastic Tape Packaging									
Lead Free		· · · · · · · · · · · · · · · · · · ·							

- 4. SHAPE, DIMENSIONS AND MATERIALS See attached drawings.
- 5. ACCOMMODATED CONDUCTORS (FPC/FFC) See attached drawings.
- 6. PACKAGING CONDITION See attached drawings.
- 7. RECOMMENDED MOUNTING PATTERN DIMENSIONS See attached drawings.
- 8. RATING
- 8-1. Voltage : A.C.100V D.C.100V
- 8-2. Current : A.C.1A D.C.1A (Refer to the following note.)
- 8-3. Operating Temperature :  $-55^{\circ}C \sim +85^{\circ}C$

(Including terminal temperature rises)

## <u>NOTE</u>

Allowable maximum current for one contact is 1A. Total allowable current for a whole connector is the following values shown below.



# 9. PERFORMANCE CHARACTERISTICS

# 9-1. Electrical Performance

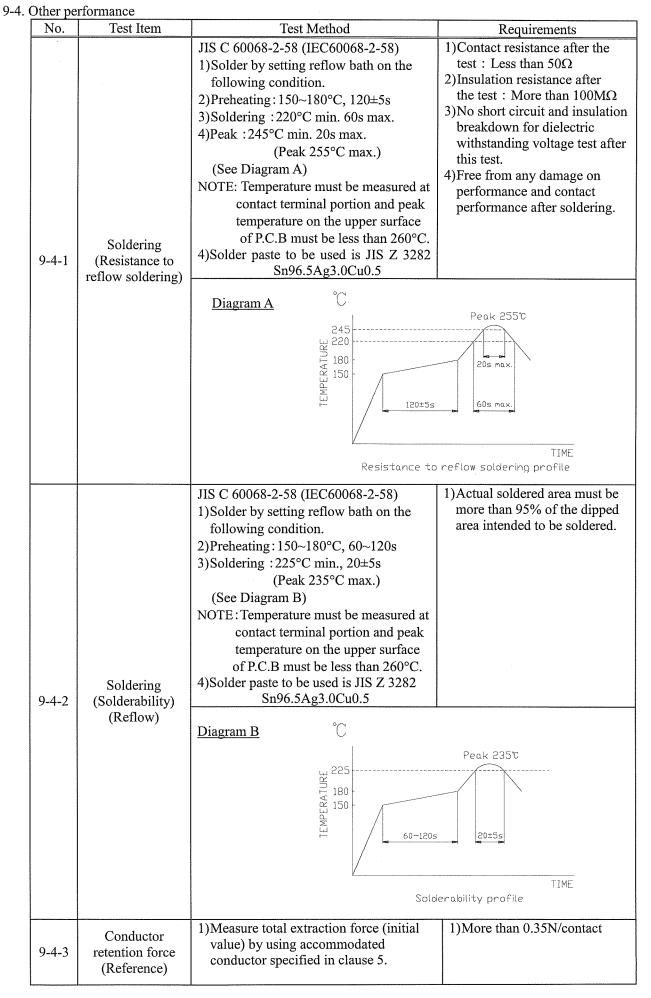
No.	Test Item	Test Method	Requirements
9-1-1	Contact resistance	<ul> <li>1)Measure contact resistance between V<sub>1</sub>-V<sub>2</sub> by voltage drop method using the following circuit by mating accommodated conductor stipulated in clause 5 after reflow soldering the connector on the P.CB. and cleaning flux dregs.</li> <li>Conductor</li> <li>V1</li> <li>V2</li> <li>Pattern</li> <li>P.C.B.</li> <li>Soldering portion</li> <li>2)Open circuit voltage         <ul> <li>Less than A.C.20mV</li> </ul> </li> </ul>	<ul> <li>1)Initial value <ul> <li>Less than 30mΩ</li> </ul> </li> <li>2)Contact resistance after the test is in accordance with the value specified in each test item.</li> </ul>
9-1-2	Insulation resistance	<ol> <li>Measure insulation resistance between adjacent contacts in a connector individual.</li> <li>Test voltage : D.C.500V</li> <li>Read value one minute after applying test voltage.</li> </ol>	1)More than 500MΩ
9-1-3	Dielectric withstanding voltage	<ol> <li>For one minute, apply A.C.500V</li> <li>between adjacent contacts in a connector individual.</li> <li>Set current : A.C.1mA</li> </ol>	1)Free from any short circuit and insulation breakdown.

# 9-2. Mechanical Performance

No.	Test Item	Test Method	Requirements		
9-2-1	Durability (Insertion and extraction)	<ol> <li>Measure contact resistance before and after the test by the method in clause</li> <li>9-1-1 by mating the accommodated conductor specified in clause 5.</li> <li>Number of Insertion and extraction         <ul> <li>30 times</li> <li>Speed of insertion and extraction</li> <li>Less than 10 times per minute.</li> </ul> </li> </ol>	<ol> <li>1)Initial contact resistance         <ul> <li>Less than 30mΩ</li> </ul> </li> <li>2)Contact resistance after the test : Less than 50mΩ</li> <li>3)Free from any defect such as break etc. on the connector and conductor.</li> </ol>		
9-2-2	Vibration (Sinusoidal)	<ul> <li>JIS C 60068-2-6 (IEC60068-2-6)</li> <li>1)Frequency range : 10 ~ 500Hz</li> <li>2)Amplitude : 0.75mm or Acceleration : 100m/s<sup>2</sup></li> <li>3)Sweep rate : 1 octave/minute</li> <li>4)Kind of test : Sweep endurance test</li> <li>5)Test time : 10 cycles</li> </ul>	<ol> <li>During the test, no circuit opening for more than 1µs.</li> <li>Free from any defect such as break, deformation, loosing and falling off etc. on each portion of the connector.</li> </ol>		

9-3. Environmental Performance

No.	Test Item	Test Method	Requirements
		JIS C 60068-2-78 (IEC60068-2-78)	
9-3-1	Damp heat (Steady state)	<ol> <li>Measure contact resistance before and after the test by the method in clause 9-1-1 by mating the accommodated conductor specified in clause 5.</li> <li>Measure insulation resistance after the test by the method in clause 9-1-2.</li> <li>Bath temperature : 40°C</li> <li>Bath humidity         <ul> <li>90 ~ 95% (relative humidity)</li> <li>Period of exposure : 48 hours</li> <li>Expose conductor and connector in mated condition and leave them under normal temperature. (Without insertion and separation)</li> </ul> </li> </ol>	<ol> <li>Initial contact resistance         <ul> <li>Less than 30mΩ</li> </ul> </li> <li>Contact resistance after the test : Less than 50mΩ</li> <li>Insulation resistance after the test : More than 100MΩ</li> </ol>
9-3-2	Salt spray	<ul> <li>JIS C 60068-2-11 (IEC60068-2-11)</li> <li>1)Measure contact resistance before and after the test according to the method in clause 9-1-1 by mating the accommodated conductor specified in clause 5.</li> <li>2)Salt solution concentration : 5%</li> <li>3)Period of exposure : 48 hours</li> <li>4)Expose conductor and connector in mated condition and leave them under normal temperature after posttreatment. (24 hours)</li> </ul>	<ol> <li>Initial contact resistance         <ul> <li>Less than 30mΩ</li> </ul> </li> <li>Contact resistance after the test : Less than 50mΩ</li> </ol>
9-3-3	Change of temperature	JIS C 0025 (IEC60068-2-14) 1)Measure contact resistance before and after the test according to the method in clause 9-1-1 by mating accommodated conductor in clause 5. 2)One cycle of temperature is as follow and test 5 cycles. <u>Step Temp.(°C) Time(min.)</u> 1 -55 $\pm$ 3 30 2 25 $\pm$ 2 2~3 3 85 $\pm$ 2 30 4 25 $\pm$ 2 2~3 3)Expose conductor and connector in mated condition and leave them under normal temperature.	<ol> <li>1)Initial contact resistance         <ul> <li>Less than 30mΩ</li> </ul> </li> <li>2)Contact resistance after the test : Less than 50mΩ</li> <li>3)Free from any defect such as crack, warping and deformation etc. on each portion the connector.</li> </ol>



## **10. INDICATION AND PACKAGING**

## 10-1. Indication

- 1) Catalog number and lot number are not indicated on the connector.
- 2) Catalog number and quantity shall be indicated on the surface of the package box.

## 10-2. Packaging

1) The connector individuals are packed by tapes with specified quantity in accordance with [JIS C 0806"Packaging of Electronic Components on Continuous Tapes (Surface Mount components)"] and put into package box in accordance with our packaging specification.

## 11. Remarks

- 11-1. Retention force for accommodated conductor specified in clause 9-4-3 differs due to it's kind, structure and surface treatment of conductor. Therefore, the value of retention force specified in the clause for performance is reference value.
- 11-2. Please use for Gold plating cable as accommodated conductor.
- 11-3. Please refer to the "Handing procedures and remarks" before use.